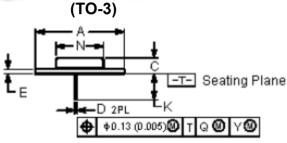




Complementary Silicon Power Transistors are designed for general purpose switching and amplifier applications

Features:

- DC current gain h_{FE} = 20 70 at I_C = 4 A dc
- Collector-emitter saturation voltage- $V_{CE(sat)}$ = 1.1 V dc (maximum) at I_C = 4 A dc
- · Excellent safe operating area
- · Pb-free packages



Dimensions	Minimum	Maximum
А	1.550 (39.37) Reference	
В	-	1.050 (26.67)
С	0.250(6.35)	0.335 (8.51)
D	0.038 (0.97)	0.043 (1.09)
E	0.055 (1.40)	0.070 (1.77)
G	0.430 (10.92) BSC	
Н	0.215 (5.46) BSC	
K	0.440 (11.18)	0.480 (12.19)
L	0.665 (16.89) BSC	
N	-	0.830 (21.08)
Q	0.151 (3.84)	0.165 (4.19)
U	1.187 (30.15) BSC	
V	0.131 (3.33)	0.188 (4.77)

Dimensions: Inches Millimetres

15 Amperes Power Transistors Complementary Silicon 60 Volts, 115 Watts

-		-Y- G H
†	-Q-	↑_+ ∞5@ T Y @]

Style 1: Pin 1. Base 2. Emitter Collector (Case)

2. Emitter Collector (Case)

Maximum Ratings

_	T			
Parameter	Symbol	Value	Unit	
Collector-Emitter Voltage	V _{CEO}	60	V dc	
Collector-Emitter Voltage	V _{CER}	70		
Collector-Base Voltage	V _{CB}	100		
Emitter-Base Voltage	V _{EB}	7		
Collector Current-Continuous	I _C	15	A dc	
Base Current	I _B	7		
Total Power Dissipation at T _C = 25°C Derate Above 25°C	P _D	115 0.657	W W/°C	
Operating and Storage Junction Temperature Range	T _J , T _{STG}	-65 to +200	°C	

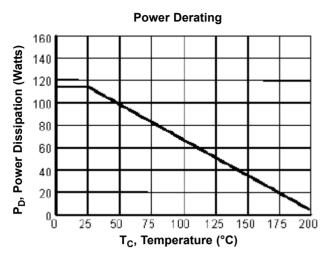
Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.





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Thermal Characteristics

Characteristic	Symbol	Maximum	Unit
Thermal Resistance, Junction to Case	$R_{ hetajc}$	1.52	°C/W

Electrical Characteristics (T_c = 25°C unless otherwise noted)

Characteristic	Symbol	Minimum	Maximum	Unit
OFF Characteristics*				
Collector-Emitter Sustaining Voltage (Note 1) $(I_C = 200 \text{ mA}, I_B = 0)$	V _{CEO (sus)}	60	-	- V dc
Collector-Emitter Sustaining Voltage (Note 1) (I_C = 200 mA, R_{BE} = 100 Ω)	V _{CE (sus)}	70	-	
Collector Cut off Current $(V_{CE} = 30 \text{ V dc}, I_{B} = 0)$	I _{CEO}	-	0.7	
Collector Cut off Current (V_{CE} = 100 V dc $V_{BE (off)}$ = 1.5 V dc) (V_{CE} = 100 V dc $V_{BE (off)}$ = 1.5 V dc, T_{C} = 150°C)	I _{CEX}	-	1 5	mA dc
Emitter Cut off Current (V _{EB} =7 V dc, I _C = 0)	I _{EBO}	-	5	
ON Characteristics* (Note 1)				
DC Current Gain ($I_C = 4 \text{ A}, V_{CE} = 4 \text{ mA dc}$) ($I_C = 10 \text{ A}, V_{CE} = 4 \text{ V dc}$)	h _{FE}	20 5	70	-
Collector-Emitter Saturation Voltage ($I_C = 4 \text{ A dc}$, $I_B = 400 \text{ A dc}$) ($I_C = 10 \text{ A dc}$, $I_B = 3.3 \text{ A dc}$)	V _{CE (sat)}	-	1.1 3	V dc
Base-Emitter on Voltage $(I_C = 4 \text{ A dc}, V_{CE} = 4 \text{ V dc})$	V _{BE (on)}	-	1.5	
Second Breakdown				
Second Breakdown Collector Current with Base Forward Biased (VCE = 40V dc, t = 1.0s, Non Repetitive)	I _{S/b}	2.87	-	A dc

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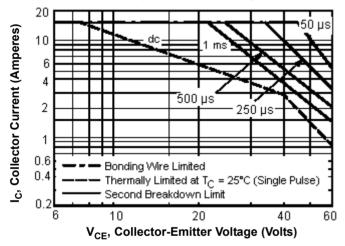


Electrical Characteristics (T_c = 25°C unless otherwise noted)

Characteristic	Symbol	Minimum	Maximum	Unit
Dynamic Characteristics				
Current Gain-Bandwidth Product (2) $(I_C = 0.5 \text{ A dc}, V_{CE} = 10 \text{ V dc}, f = 1 \text{ MHz})$	f _T	2.5	-	MHz
*Small-Signal Current Gain $(I_C = 1 \text{ A dc}, V_{CE} = 4 \text{ V dc}, f = 1 \text{ KHz})$	h _{fe}	15	120	pF
*Small-Signal Current Gain Cut off Frequency (V_{CE} = 4 Vdc, I_{C} = 1 A dc, f = 1 KHz)	f _{hfe}	10	-	KHz

^{*} Indicates Within JEDEC Registration. (MJ2955)

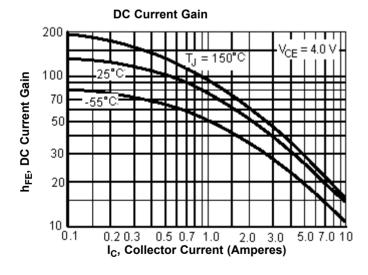
Active Region Safe Operating Area

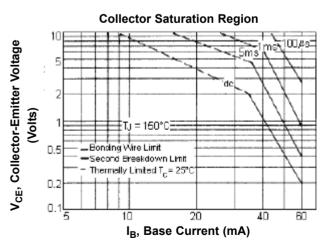


There are two limitation on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than curves indicate.

The data is based on $T_C = 25^{\circ}C$: T_{CE} is variable depending on

The data is based on $T_C = 25^{\circ}C$; $T_{J (pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated for temperature according





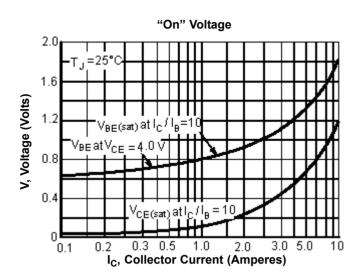




^{1.} Pulse Test : Pulse Width = 300 µs, Duty Cycle ≤2.0%

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Part Number Table

Description	Part Number	
Transistor, PNP, TO-3	MJ2955	

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